

技術振興公認の専攻門在

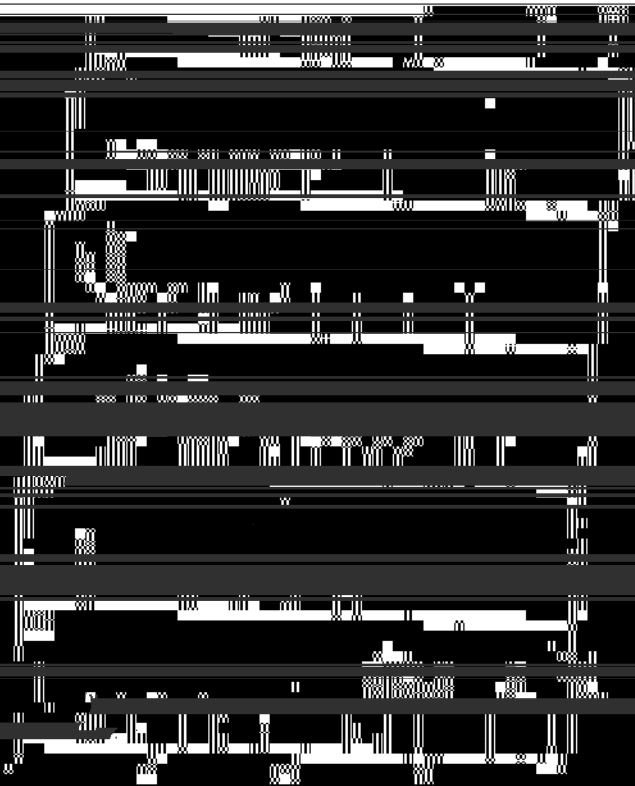
岡田 忠 司

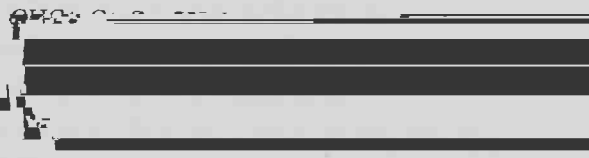
“Active” Supports Research and Development

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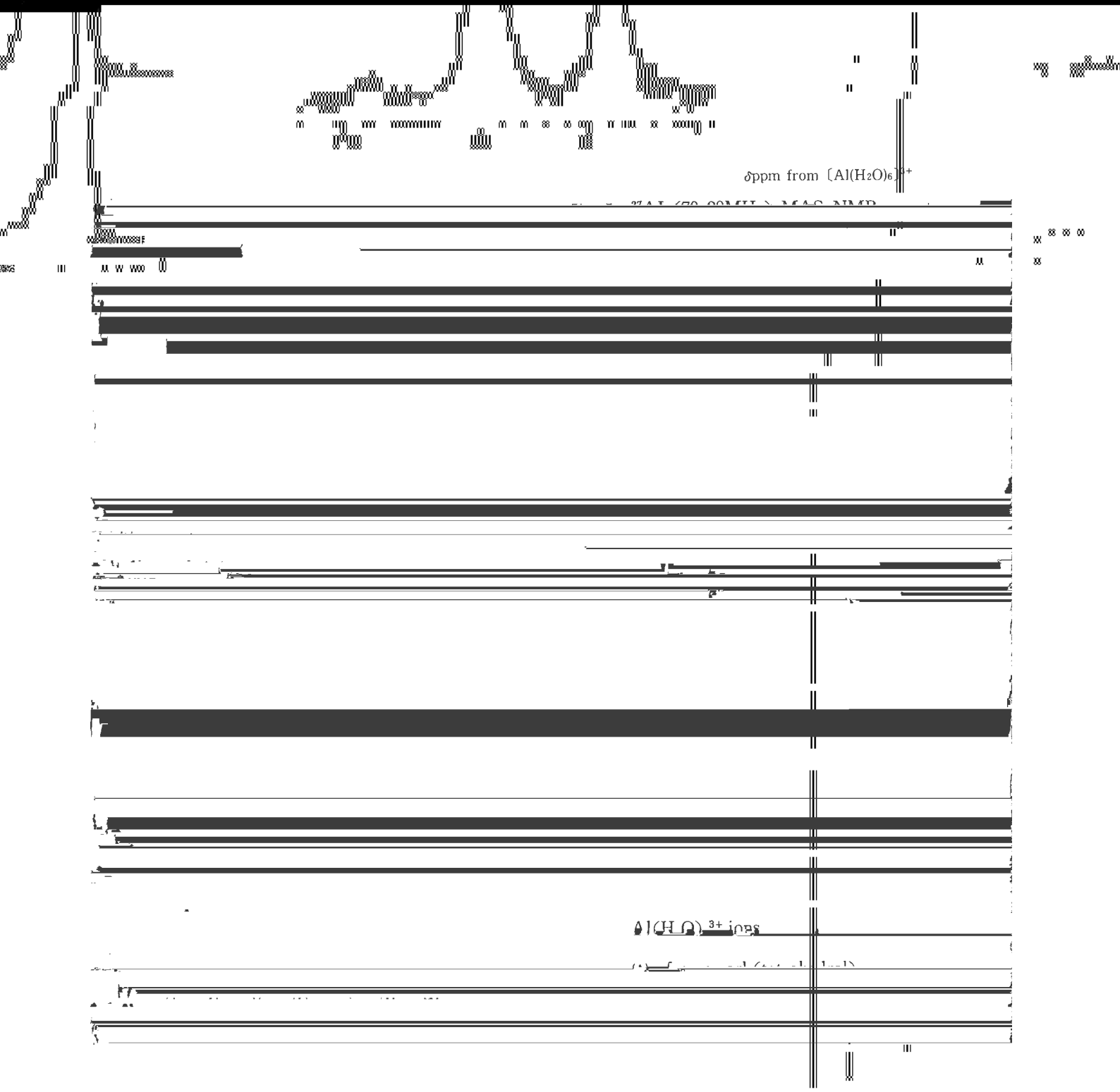


フィードバックさねた

(A)

(A)

(B)



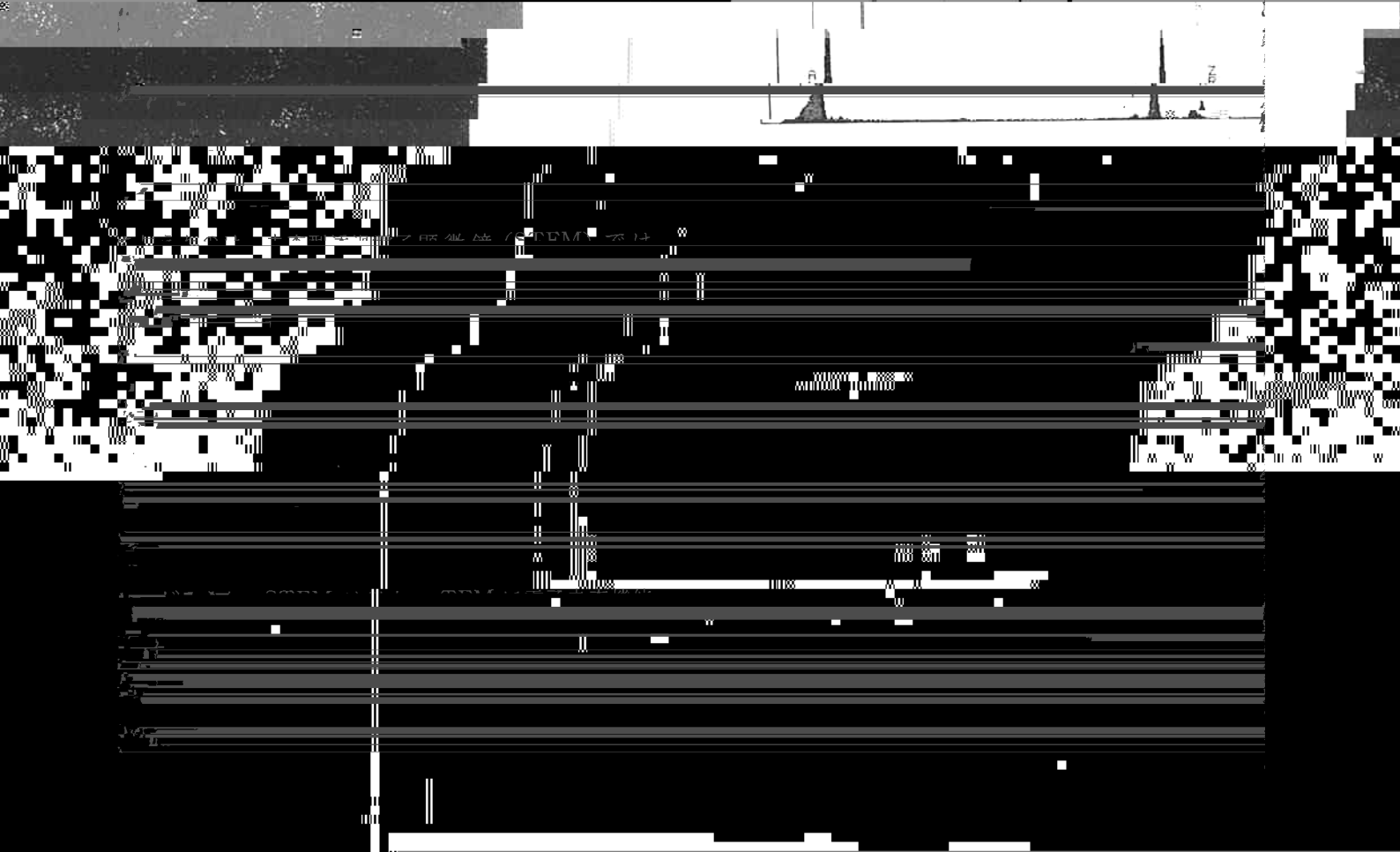
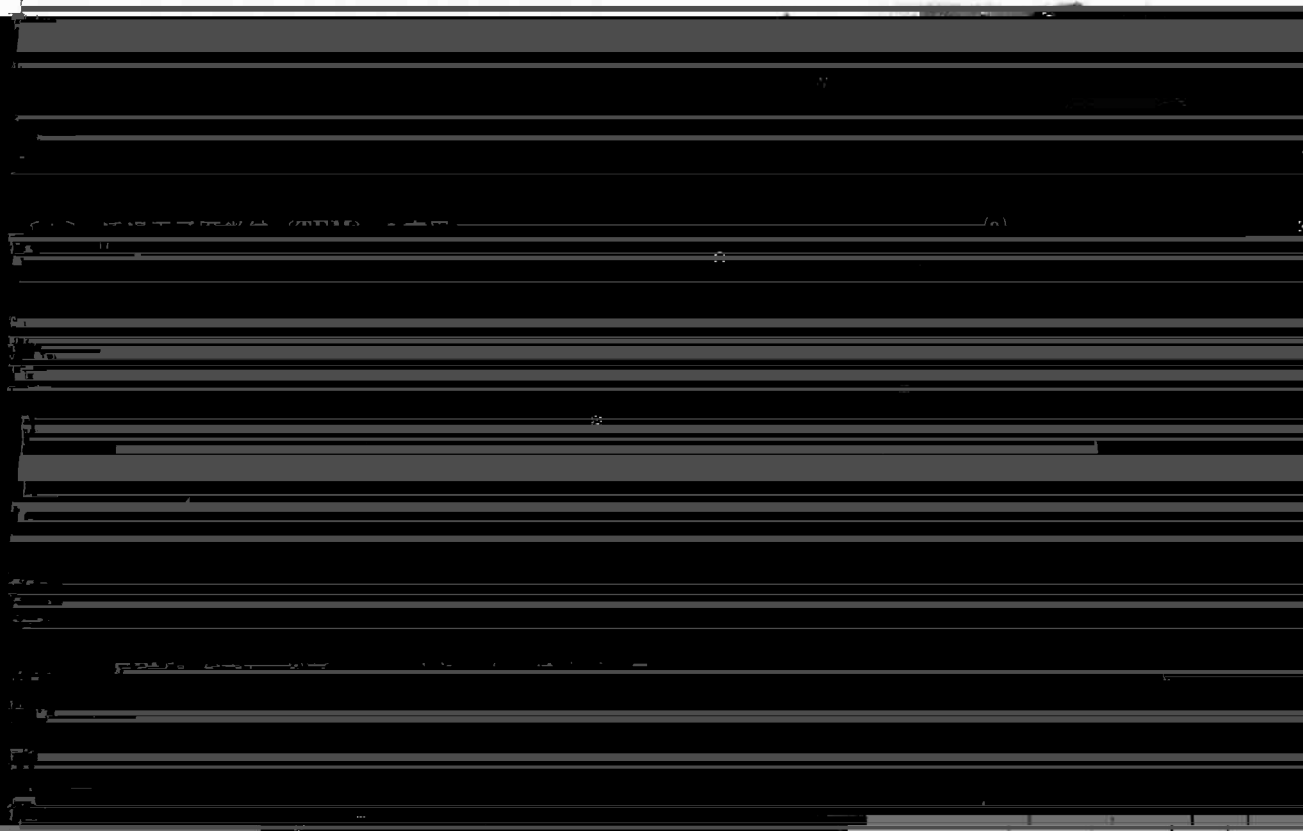
(a)

(c)

YAPPING

Fig. 9 (a) Scanning electron micrograph of the surface of the film after 10 days of YAPPING





7:14:30 AM

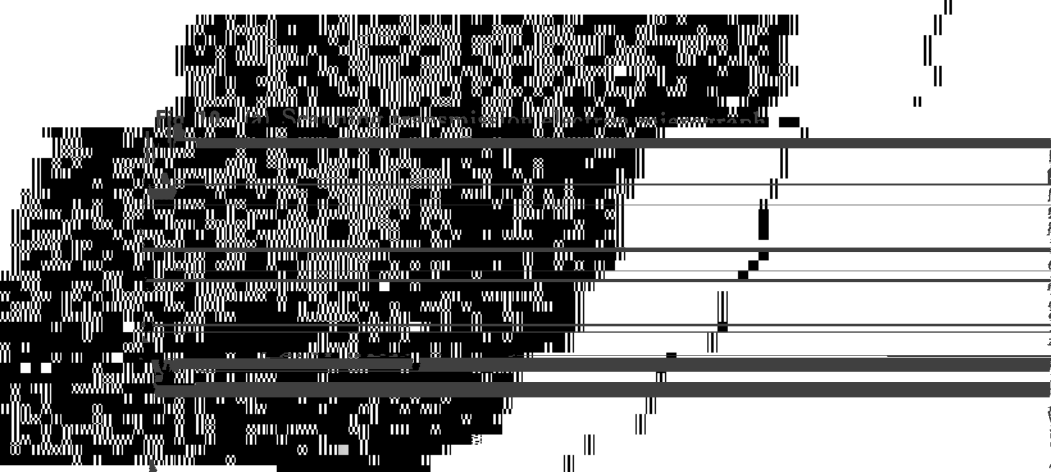
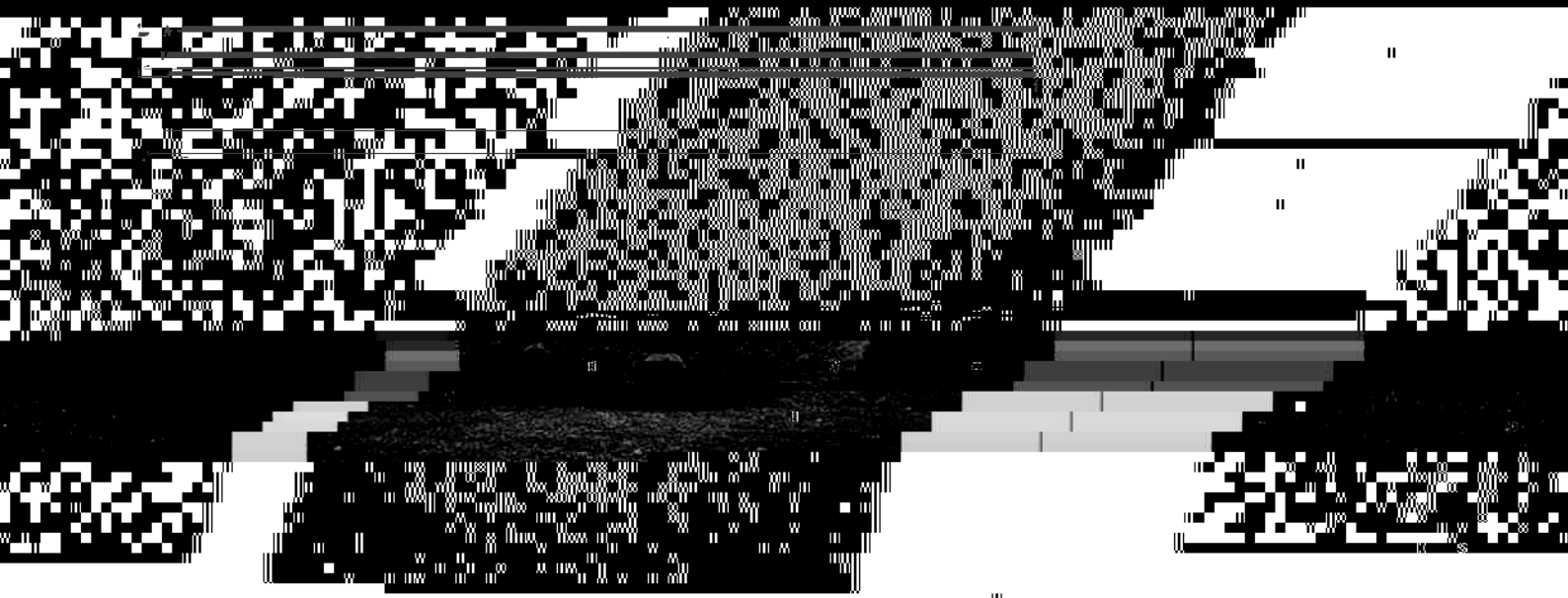
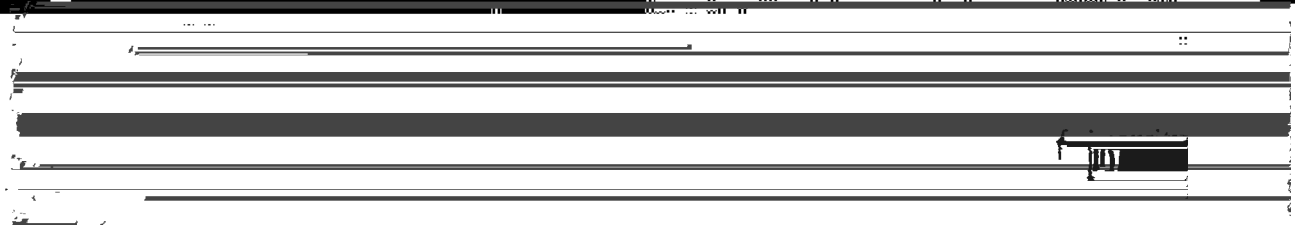
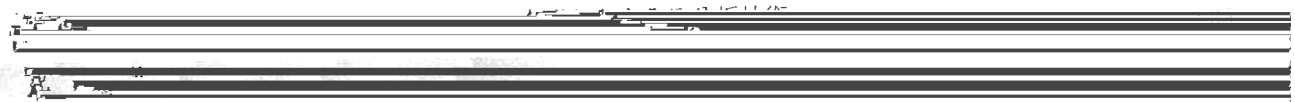


Fig. 1. Scanning error



1970年 7月 20日 昭和45年7月20日 異物の解体

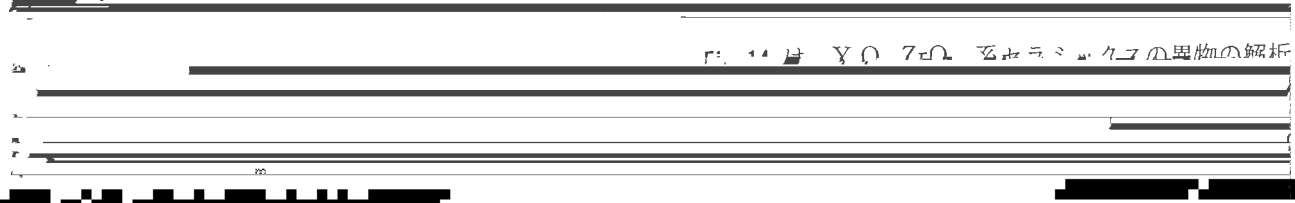




Fig. 14

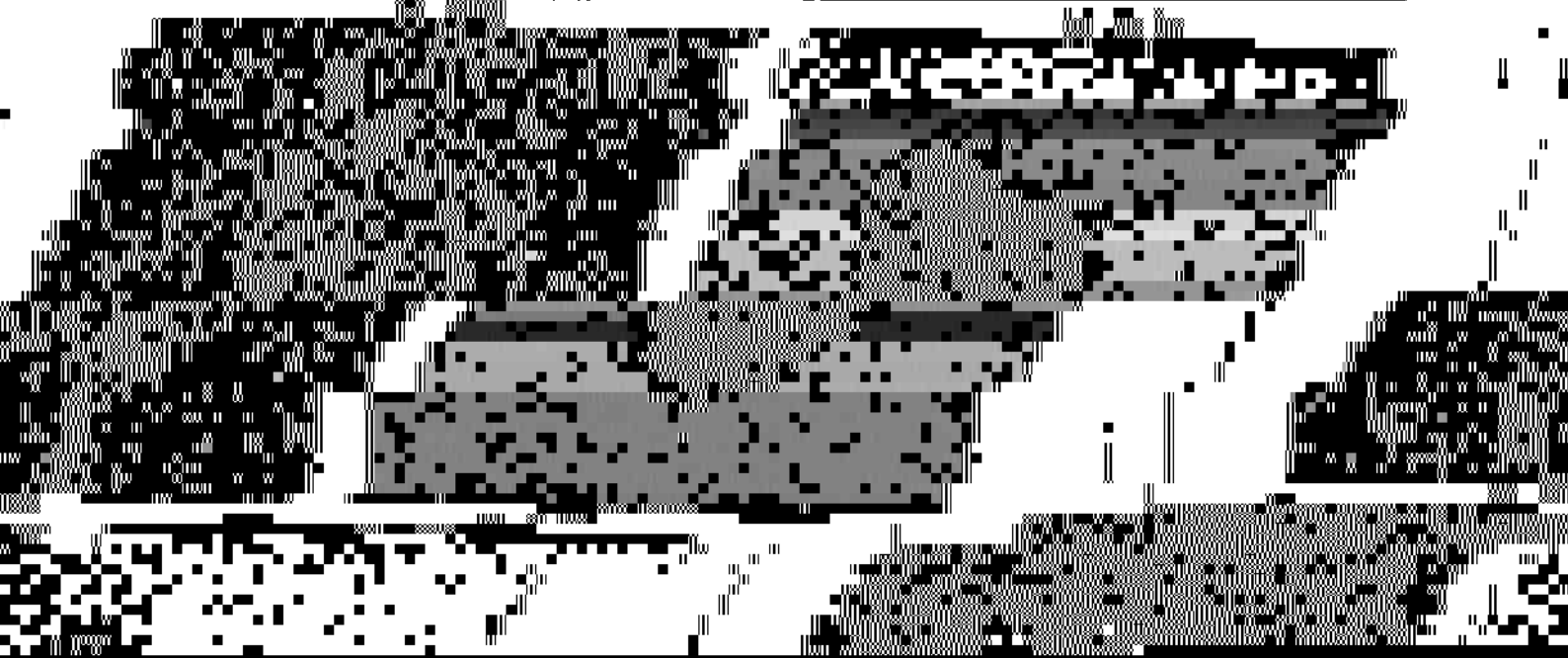


Fig. 15 (a). Secondary electron image of



